SN54ABT541, SN74ABT541 OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

SCBS093D - JANUARY 1991 - JULY 1994

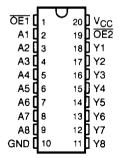
- State-of-the-Art EPIC-IIB™ BICMOS Design Significantly Reduces Power Dissipation
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V_{OLP} (Output Ground Bounce)
 1 V at V_{CC} = 5 V, T_A = 25°C
- High-Drive Outputs (-32-mA I_{OH}, 64-mA I_{OL})
- Package Options Include Plastic Small-Outline (DW) and Shrink
 Small-Outline (DB) Packages, Ceramic Chip Carriers (FK) and Flatpacks (W), and Standard Plastic (N) and Ceramic (J) DIPS

description

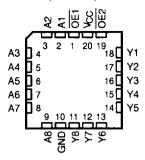
The 'ABT541 octal buffers and line drivers are ideal for driving bus lines or buffering memory address registers. The devices feature inputs and outputs on opposite sides of the package to facilitate printed-circuit-board layout.

The 3-state control gate is a 2-input AND gate with active-low inputs so that if either output-enable $(\overline{OE1} \text{ or } \overline{OE2})$ input is high, all eight outputs are in the high-impedance state.

SN54ABT541 . . . J OR W PACKAGE SN74ABT541 . . . DB, DW, OR N PACKAGE (TOP VIEW)



SN54ABT541 . . . FK PACKAGE (TOP VIEW)



To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74ABT541 is available in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54ABT541 is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74ABT541 is characterized for operation from -40° C to 85° C.

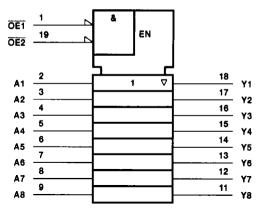
FUNCTION TABLE

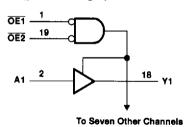
	INPUTS		OUTPUT
OE1	OE2	Α	Y
L	L	L	L
L	L	Н	н
н	X	Х	z
X	н	Х	z

EPIC-IIB is a trademark of Texas Instruments Incorporated.

logic symbolt

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range , V _{CC} –c).5 V to 7 V
Input voltage range, V _I (see Note 1)	0.5 V to 7 V
Voltage range applied to any output in the high state or power-off state, VO0.5	5 V to 5.5 V
Current into any output in the low state, IO: SN54ABT541	96 mA
SN74ABT541	
Input clamp current, I _{IK} (V _I < 0)	18 mA
Output clamp current, I_{OK} ($V_O < 0$)	50 mA
Maximum power dissipation at T _A = 55°C (in still air) (see Note 2): DB package	0.6 W
DW package	
N package	1.3 W
Storage temperature range	C to 150°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero. For more information, refer to the Package Thermal Considerations application note in the 1994 ABT Advanced BiCMOS Technology Data Book, literature number SCBD002B.

recommended operating conditions (see Note 3)

			SN54A	BT541	SN74A			
			MIN	MAX	MIN	MAX	UNIT	
VCC	Supply voltage	4.5	5.5	4.5	5.5	V		
VIH	High-level input voltage		2		2		V	
VIL	Low-level input voltage			0.8		0.8	V	
VI	Input voltage	0	Vcc	0	Vcc	V		
ЮН	High-level output current		-24		-32	mA		
lOL	Low-level output current		48		64	mA		
Δt/Δν	Input transition rise or fall rate	Outputs enabled		5		5	ns/V	
TA	Operating free-air temperature		-55	125	-40	85	•c	

NOTE 3: Unused or floating inputs must be held high or low.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS			T _A = 25°C			SN54ABT541		SN74ABT541		
PARAMETER				MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
VIK	$V_{CC} = 4.5 V_i$	l _I = -18 mA				-1.2		-1.2		-1.2	٧
	V _{CC} = 4.5 V,	I _{OH} = -3 mA		2.5	_		2.5		2.5		
No.	V _{CC} = 5 V,	I _{OH} = -3 mA		3			3		3		v
∨он	V _{CC} = 4.5 V	I _{OH} = -24 mA		2			2				V
	ACC = 4.9 A	1 _{OH} = -32 mA		2*					2		i
	V 45V	IOL = 48 mA				0.55		0.55			V
VOL	V _{CC} = 4.5 V	IOL = 64 mA	-			0.55*				0.55	V
lş .	V _{CC} = 5.5 V,	VI = VCC or GNI)			±1		±1		±1	ДA
¹ OZH	V _{CC} = 5.5 V,	V _O = 2.7 V				50		10		50	μА
lozl	V _{CC} = 5.5 V,	V _O = 0.5 V				-50		-10		-50	μА
loff	V _{CC} = 0,	V _I or V _O ≤ 4.5 V				±100				±100	μА
CEX	V _{CC} = 5.5 V,	V _O = 5.5 V	Outputs high			50		50		50	μА
10 [‡]	V _{CC} = 5.5 V,	V _O ≠ 2.5 V		-50	-140	-180	-50	-180	-50	-180	mA
	557		Outputs high		5	250		250		250	μA
lcc	$V_{CC} = 5.5 \text{ V},$ $V_{I} = V_{CC} \text{ or G}$		Outputs low		22	30		30		30	mA
	Al = ACC or GIAD		Outputs disabled		. 1	250		250		250	μΑ
	V _{CC} = 5.5 V,	5.5 V.	Outputs enabled			1.5		1.5		1.5	mA
∆ICC§	One input at 3.		Outputs disabled			50		50		50	μА
	Other inputs at VCC or GND Cor		Control inputs			1.5		1.5		1.5	mA
Ci	V _I ≈ 2.5 V or 0	.5 V			5_						pF
C _o	VO = 2.5 V or	0.5 V			5						pF

^{*} On products compliant to MIL-STD-883, Class B, this parameter does not apply.

[†] All typical values are at $V_{CC} = 5 \text{ V}$.

[‡] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

[§] This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

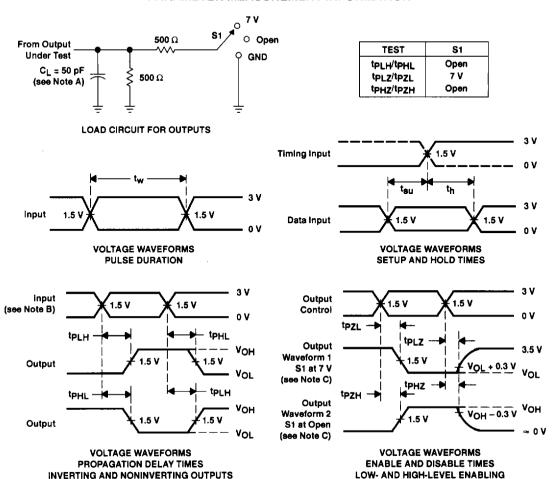
SN54ABT541, SN74ABT541 OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

SCBS093D - JANUARY 1991 - JULY 1994

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _t	V _{CC} = 5 V, T _A = 25°C			SN54ABT541		SN74ABT541	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
[†] PLH	A	Y	1	2.6	4.1	1	4.6	1	4.6	- ns i
[†] PHL			1	2.9	4.2	1	4.7	1	4.6	
t _{PZH}	ŌĒ	Υ	1.1	3.1	4.8	1.1	5.4	1.1	5.3	-l ns
†PZL			2.1	4.4	5.9	2.1	7	2.1	6.4	
^t PHZ	ŌĒ	ŌE Y	2.1	5.1	6.6	2.1	7.5	2.1	7.1	ns
[†] PLZ			1.7	4.7	6.2	1.7	6.7	1.7	6.7	

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_i includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_f ≤ 2.5 ns, t_f ≤ 2.5 ns.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms